



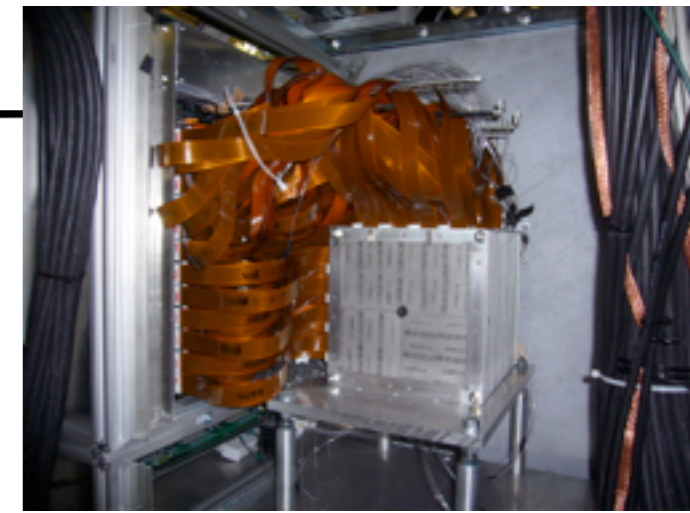
Test results of an scintillator ecal layer with embedded electronics

Technological prototype of ScEcal

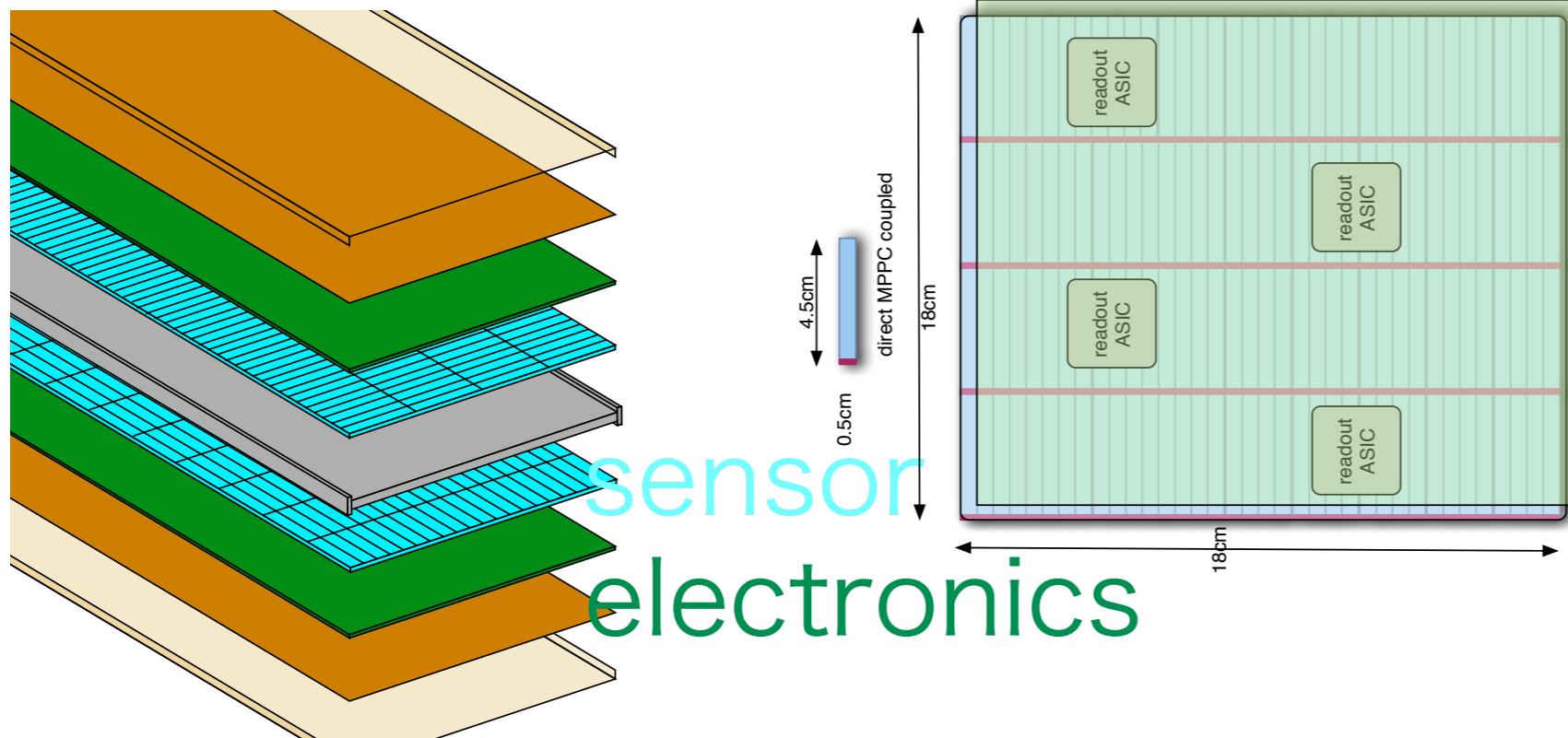
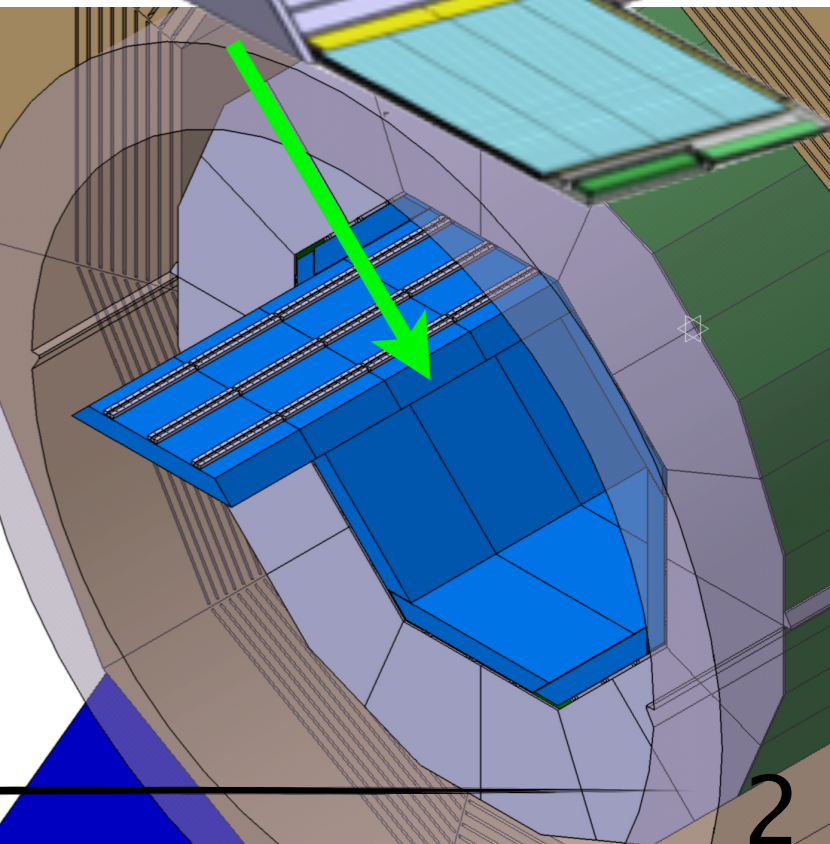
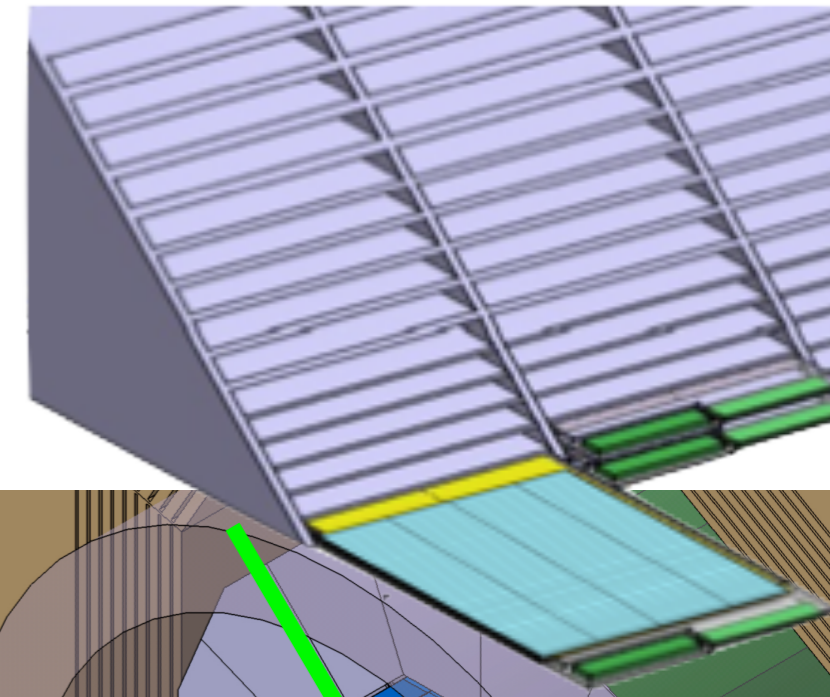
Tomohisa Ogawa , Tohru Takeshita
for ScECAL - CALICE-Asia
ECFA/DESY May/2013

Technological prototype

- ▶ From physics prototype to the real calorimeter
- ▶ Technological prototype sensor layer with embedded electronics



- physics prototype
TestBeam2009@FNAL



scintillator ECAL Technological prototype : scecal

- ▶ sensor = scintillator strip and photo-sensor (MPPC)

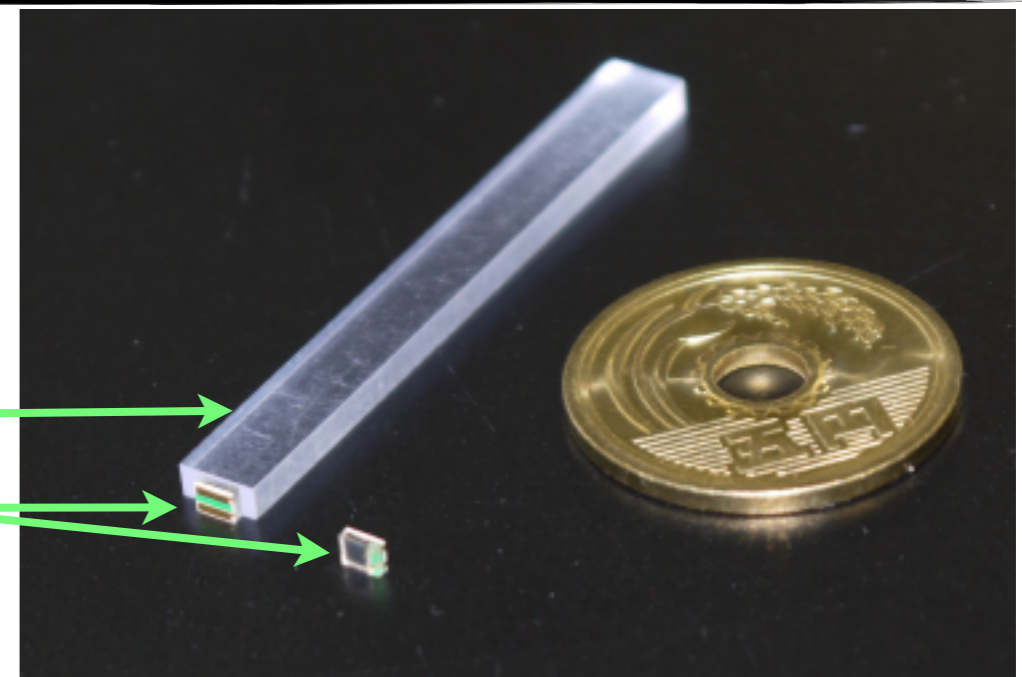
scintillator : $2 \times 5 \times 45 \text{ mm}^3$
MPPC : $1 \times 1 \text{ mm}^2$ 1600pix.
direct coupling without any glue

- ▶ embedded electronics =
EBU : ECAL Base Unit

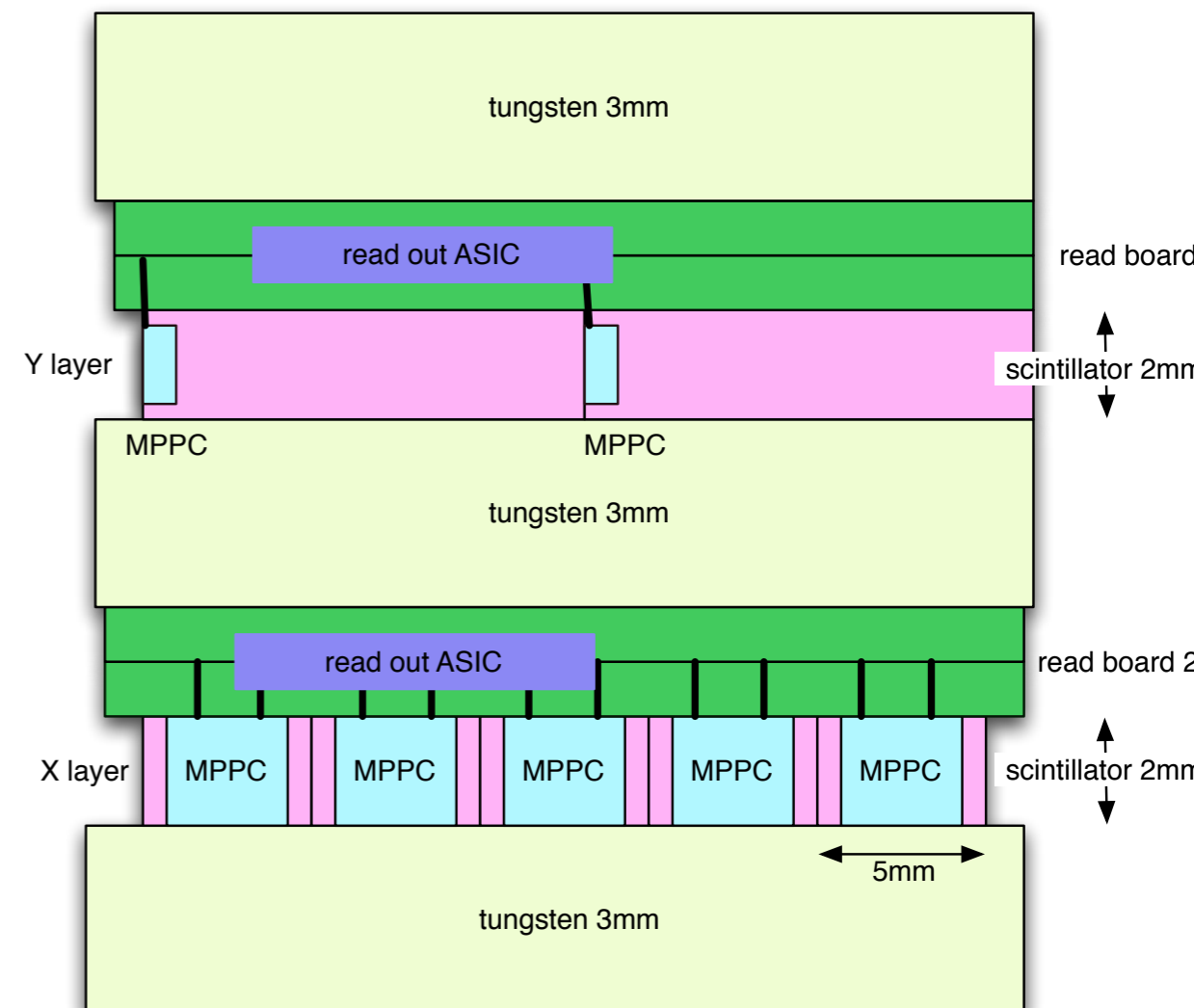
ASIC=SPIROC2b

Bias supply
amp. ADC/ TDC
Readout I/F

calibration via LED

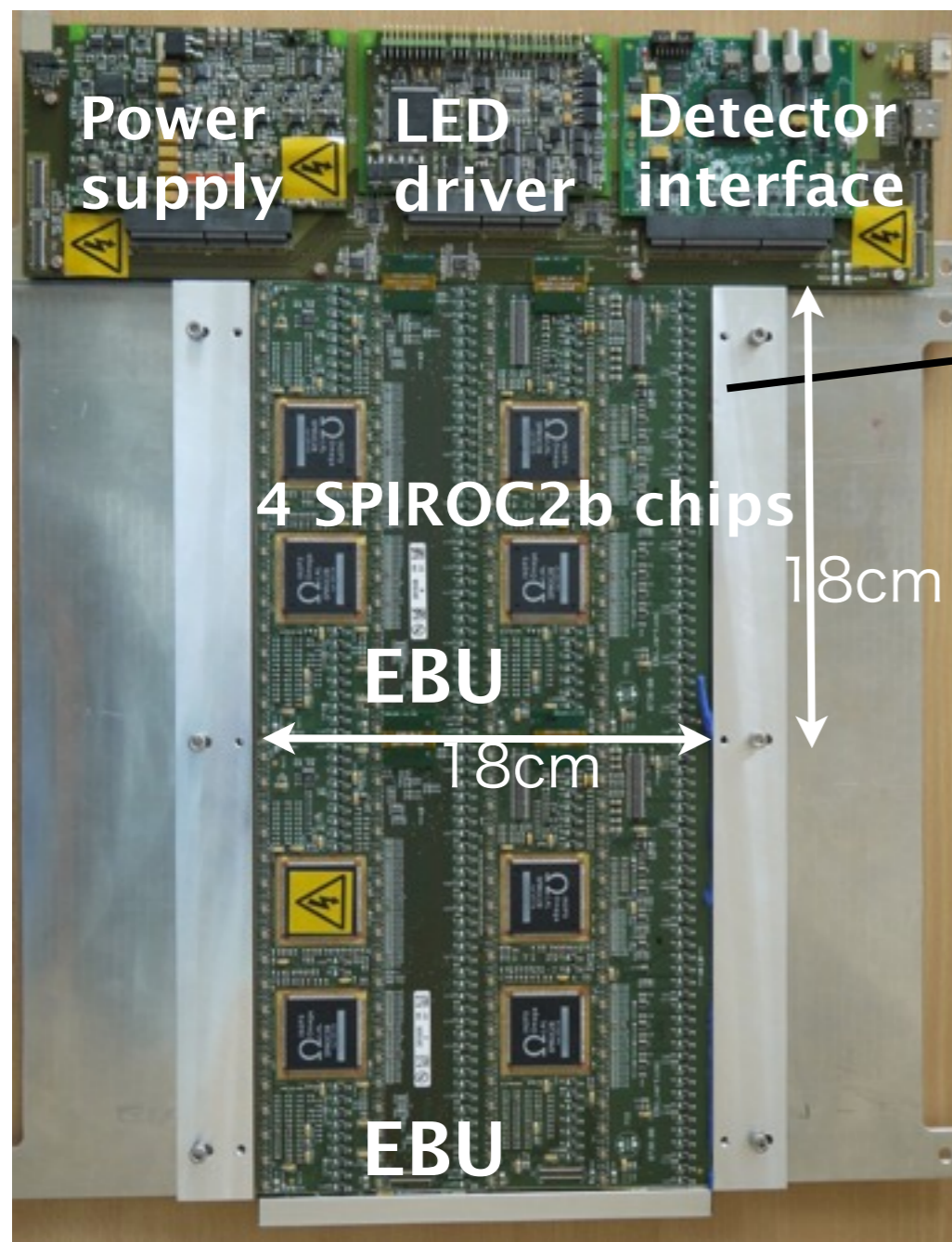


side view of scecal

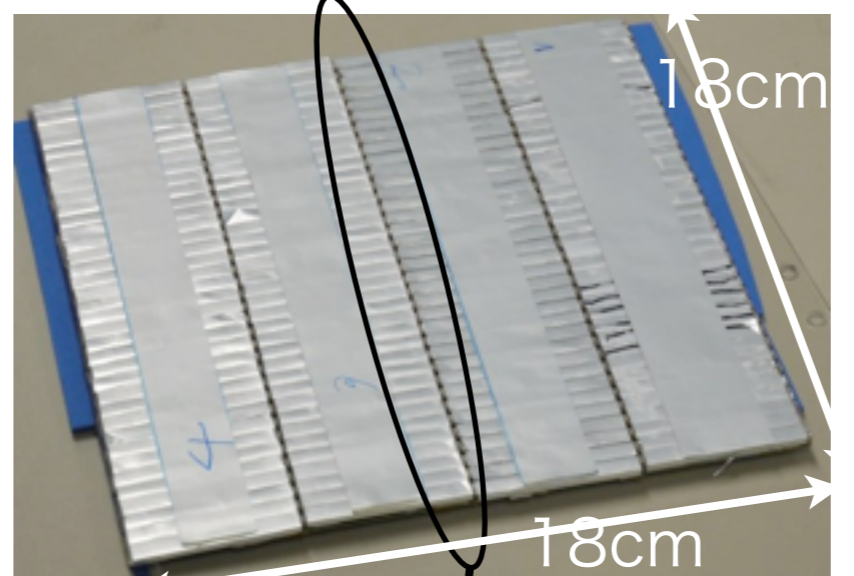


actual ScEcal technological prototype

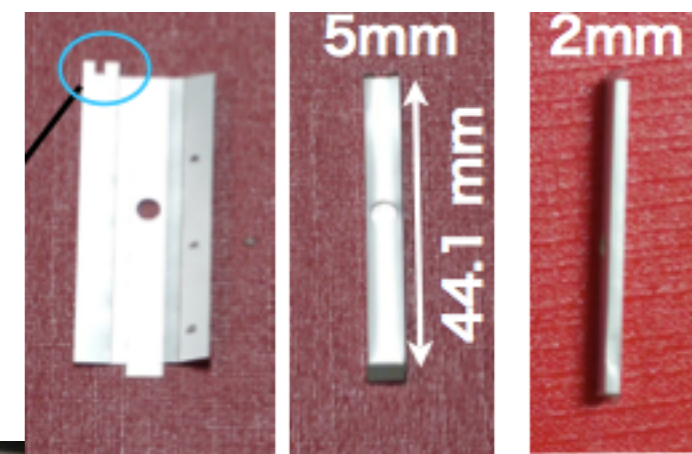
- ▶ 4 SPIROCs on a EBU control 144 = 4 x 36 channels.
- ▶ board is developed by DESY ~ AHCAL
- ▶ detector interface board (DIF)



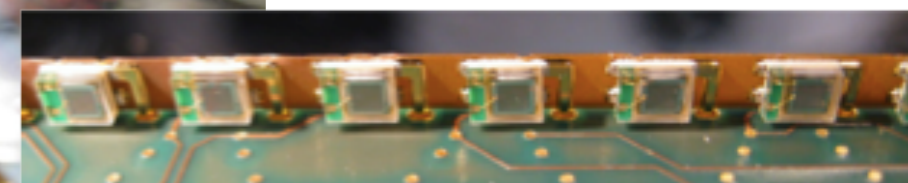
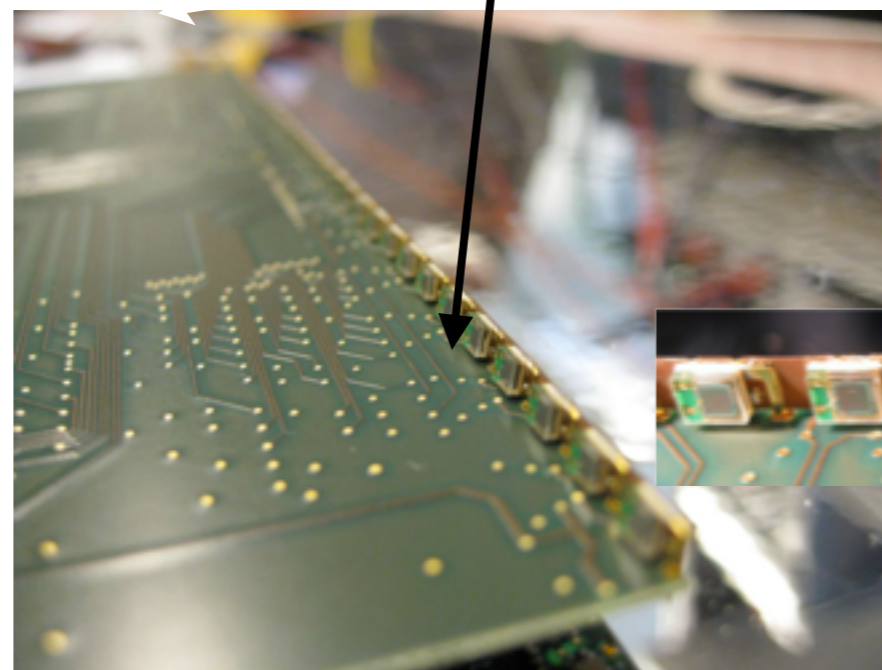
-back side of EBU



- a scintillator covered by reflector film

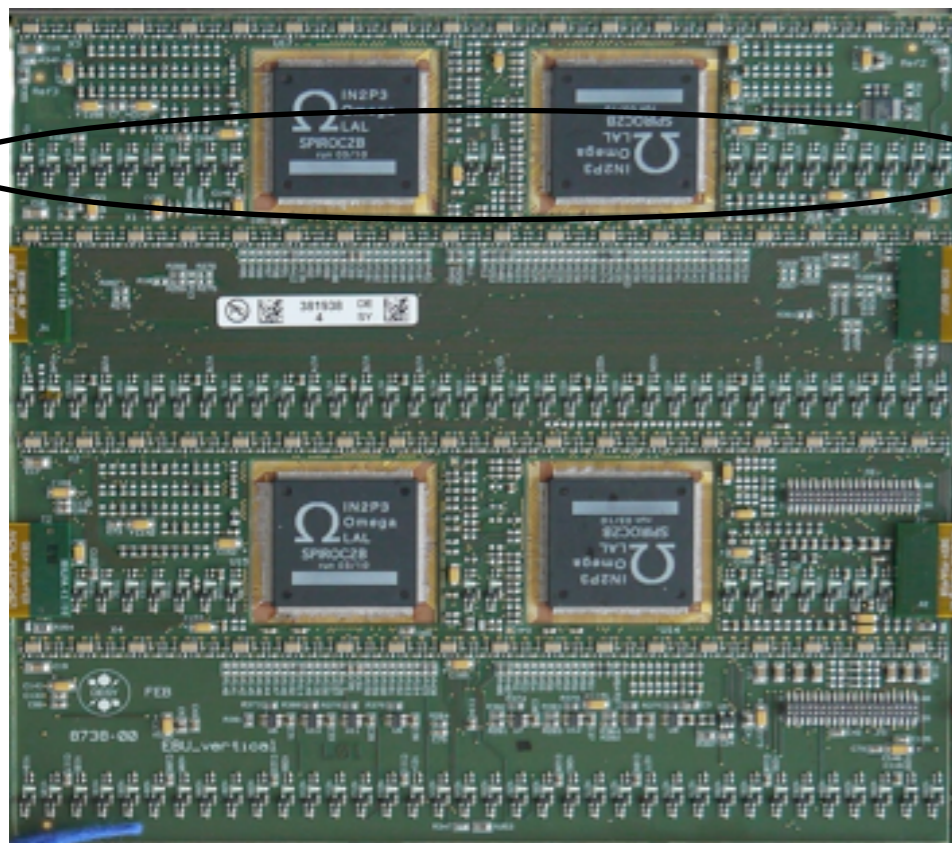


- MPPC ladder

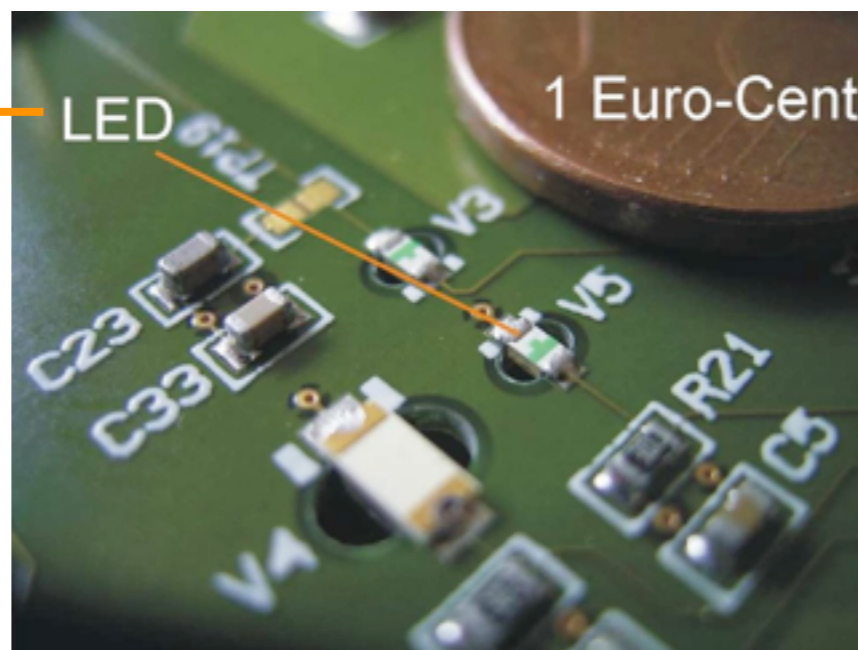


LED calibration and gain monitoring system

a EBU



an LED & its hole to a scintillator

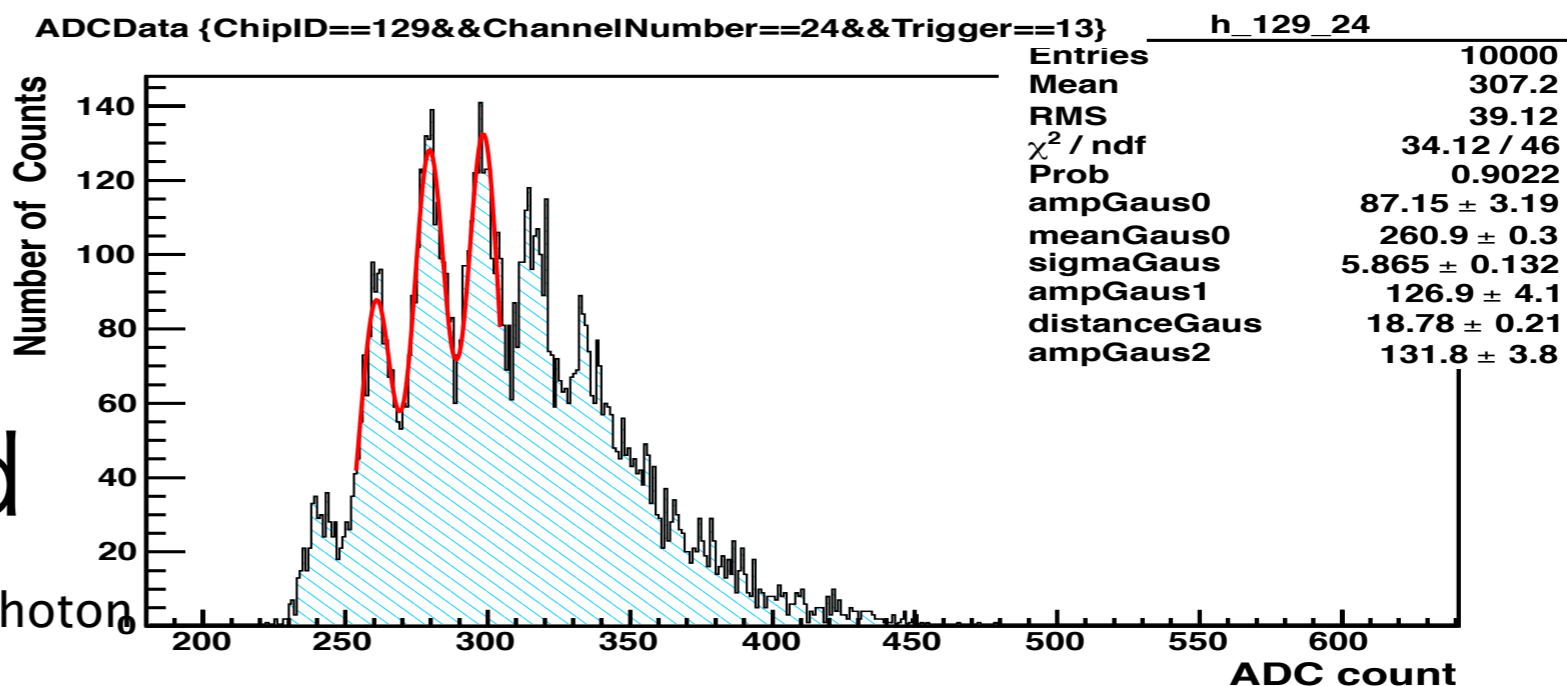


- EBU has LEDs for each channel except on chips or connector

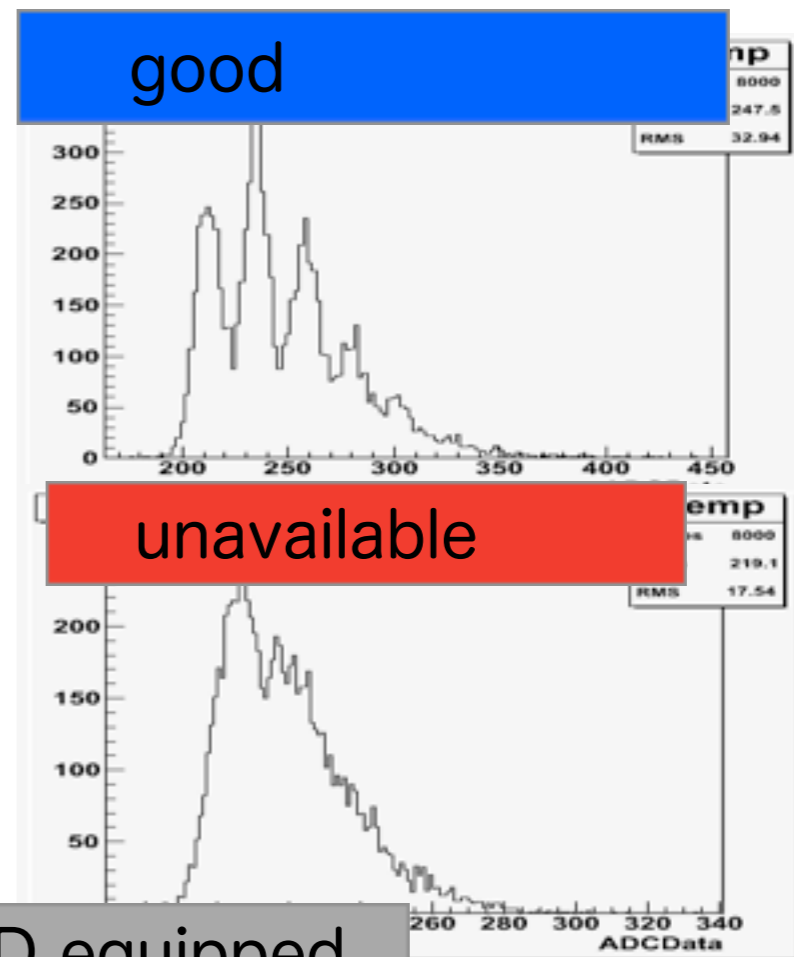
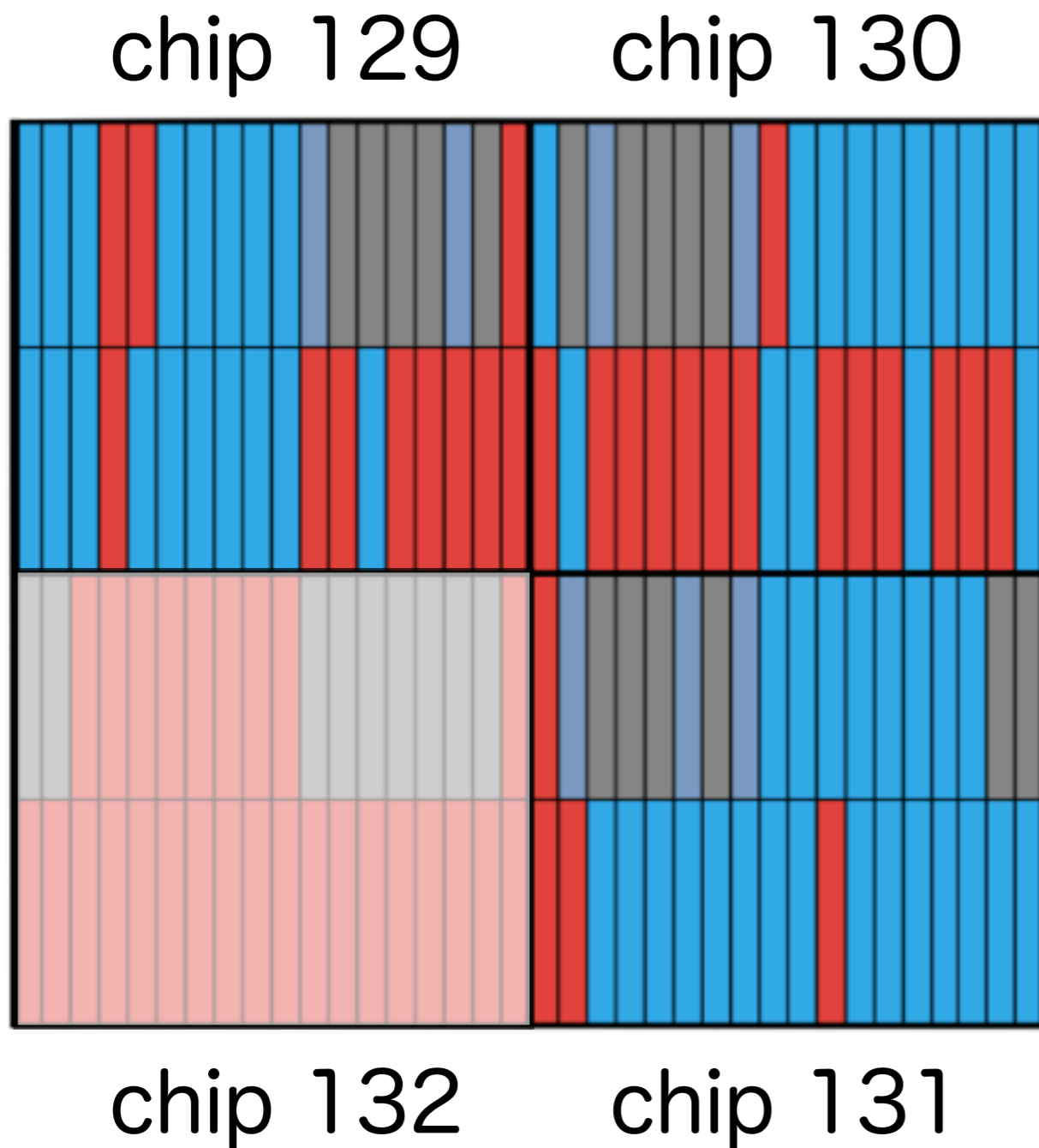
Photo electron peaks are measured by LED lights

gain monitored

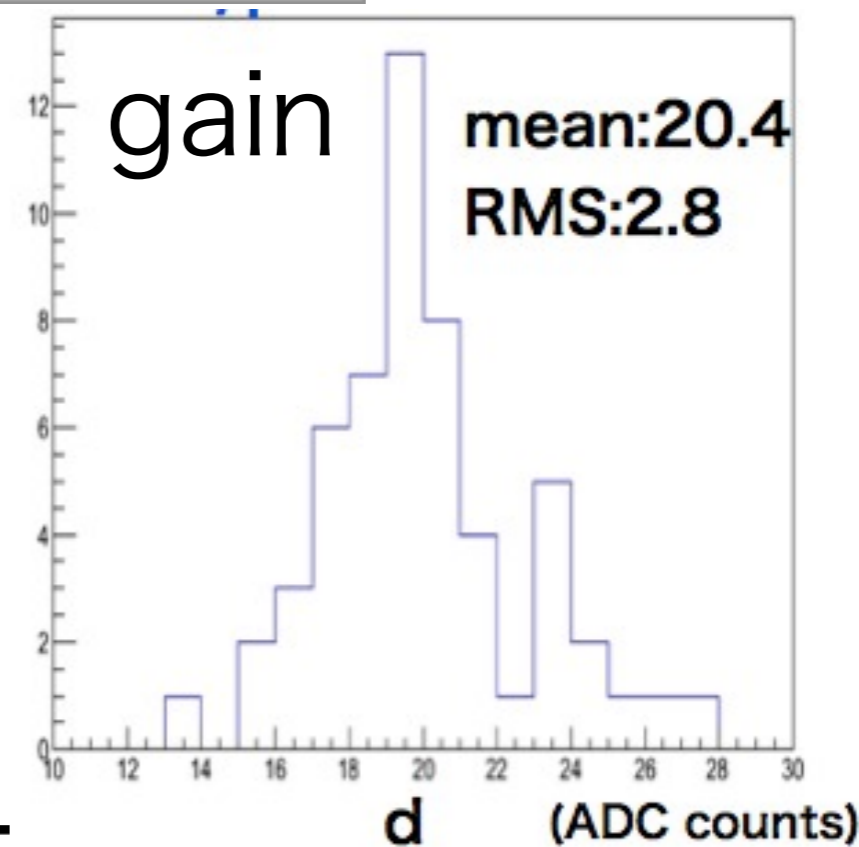
- ADC distribution to measure #photon



results of LED gain monitoring system



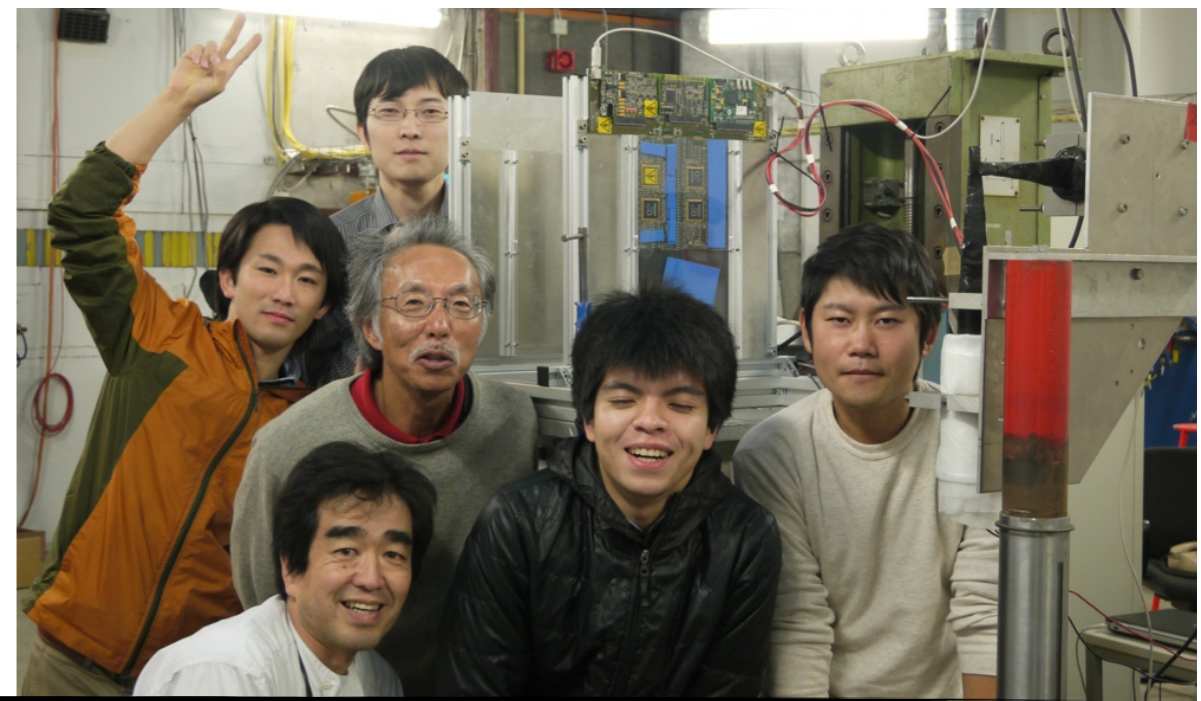
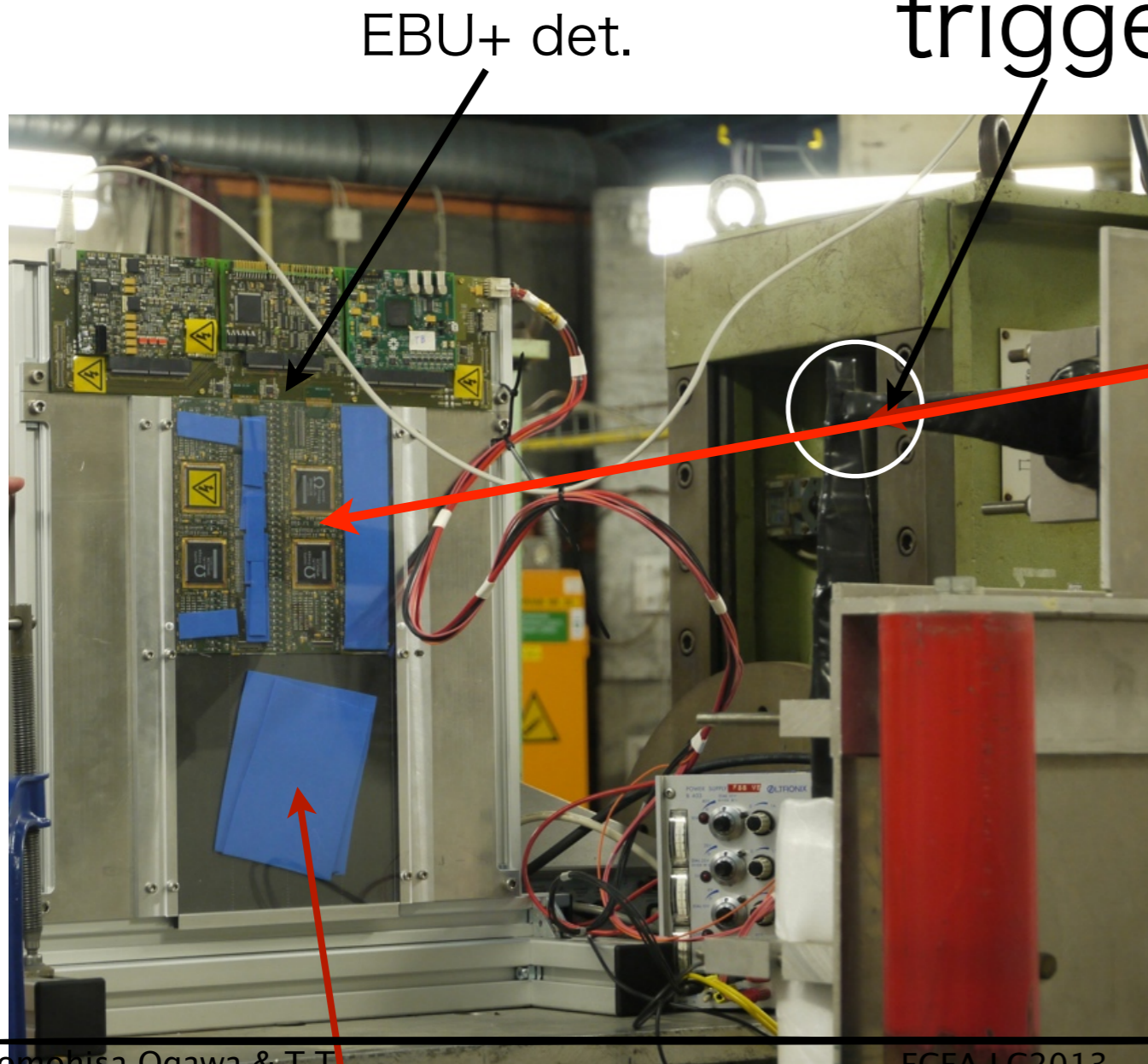
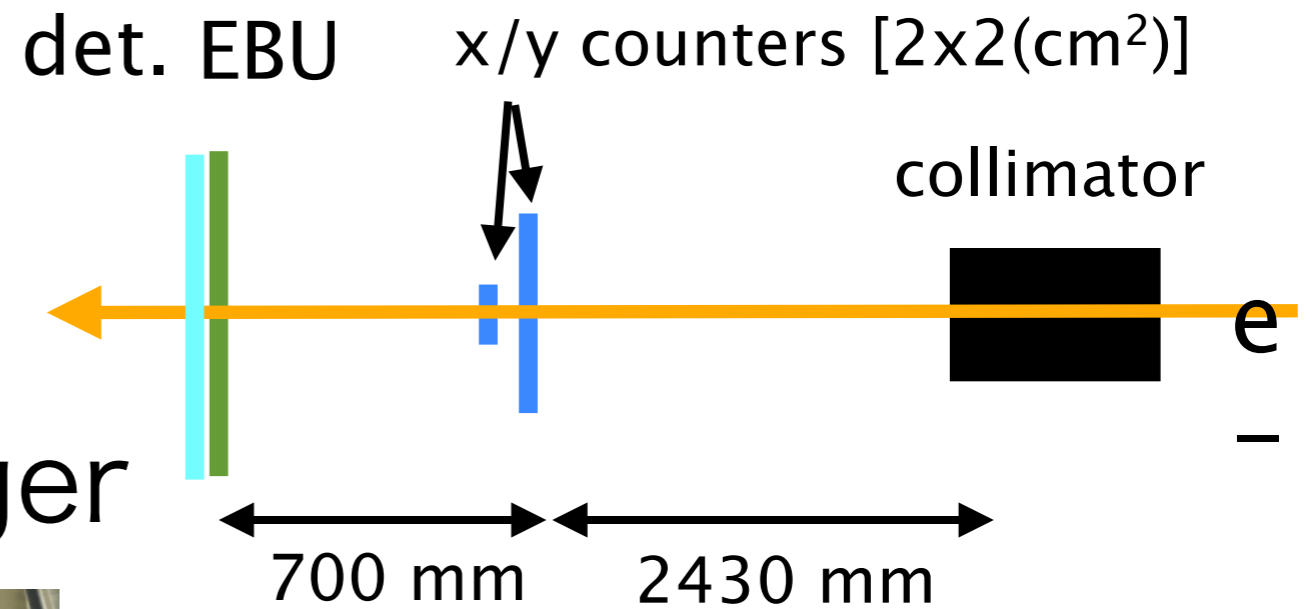
no LED equipped



- $(\# \text{good channels}) / (144 - 32) = 50\%$.
- There is no channel on ASIC132 measured correctly.

Beam test at DESY Oct-2012

- ▶ response to MIPS are measured at DEST st, 26

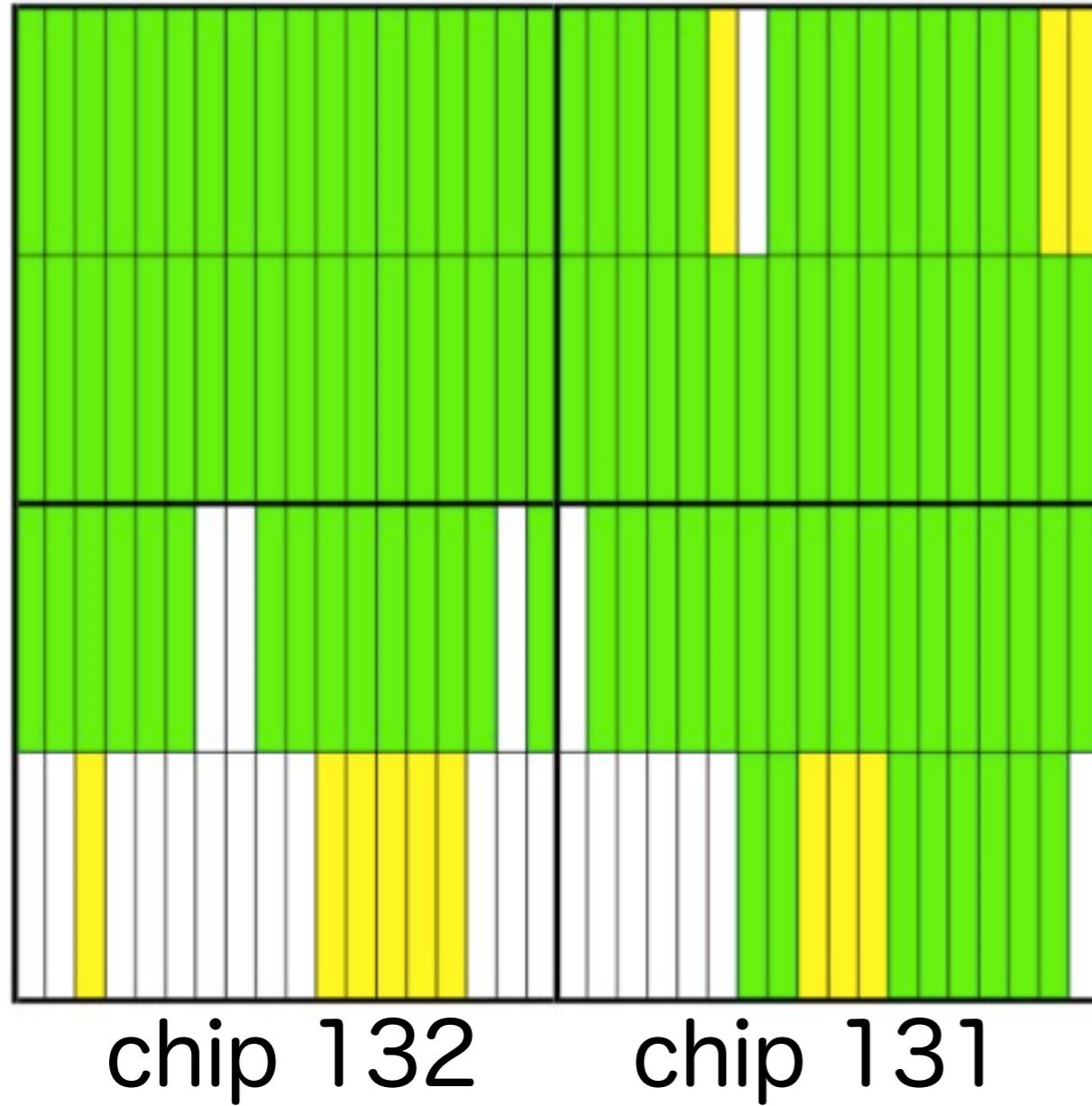


Response to 3GeV electron events

electrons at the center positions

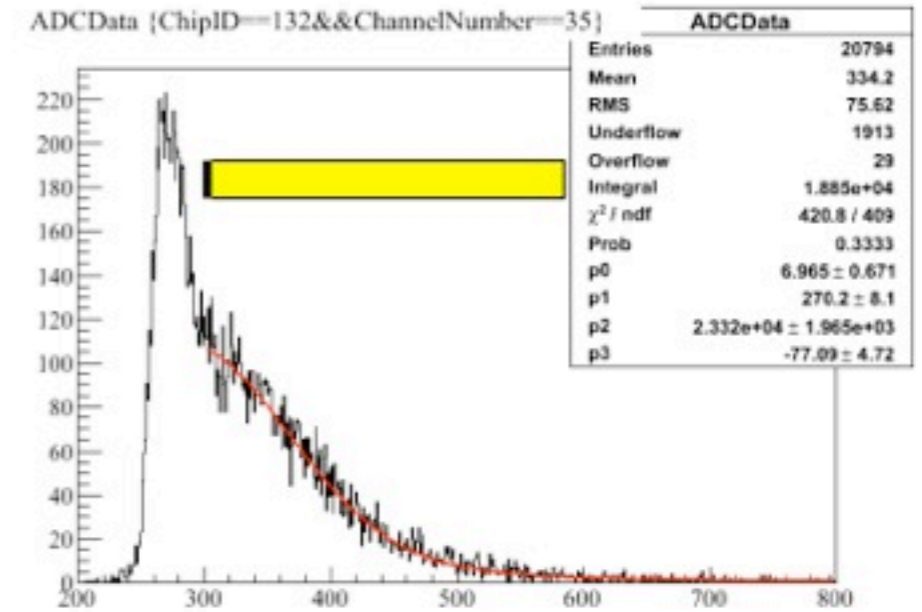
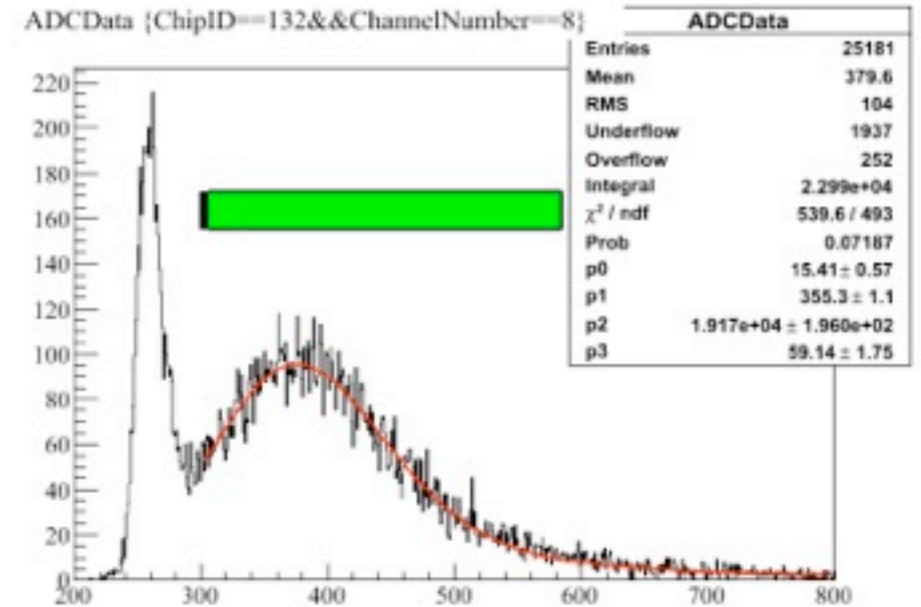
chip 129

chip 130



- 75% channels have succeeded to have good MIP distribution

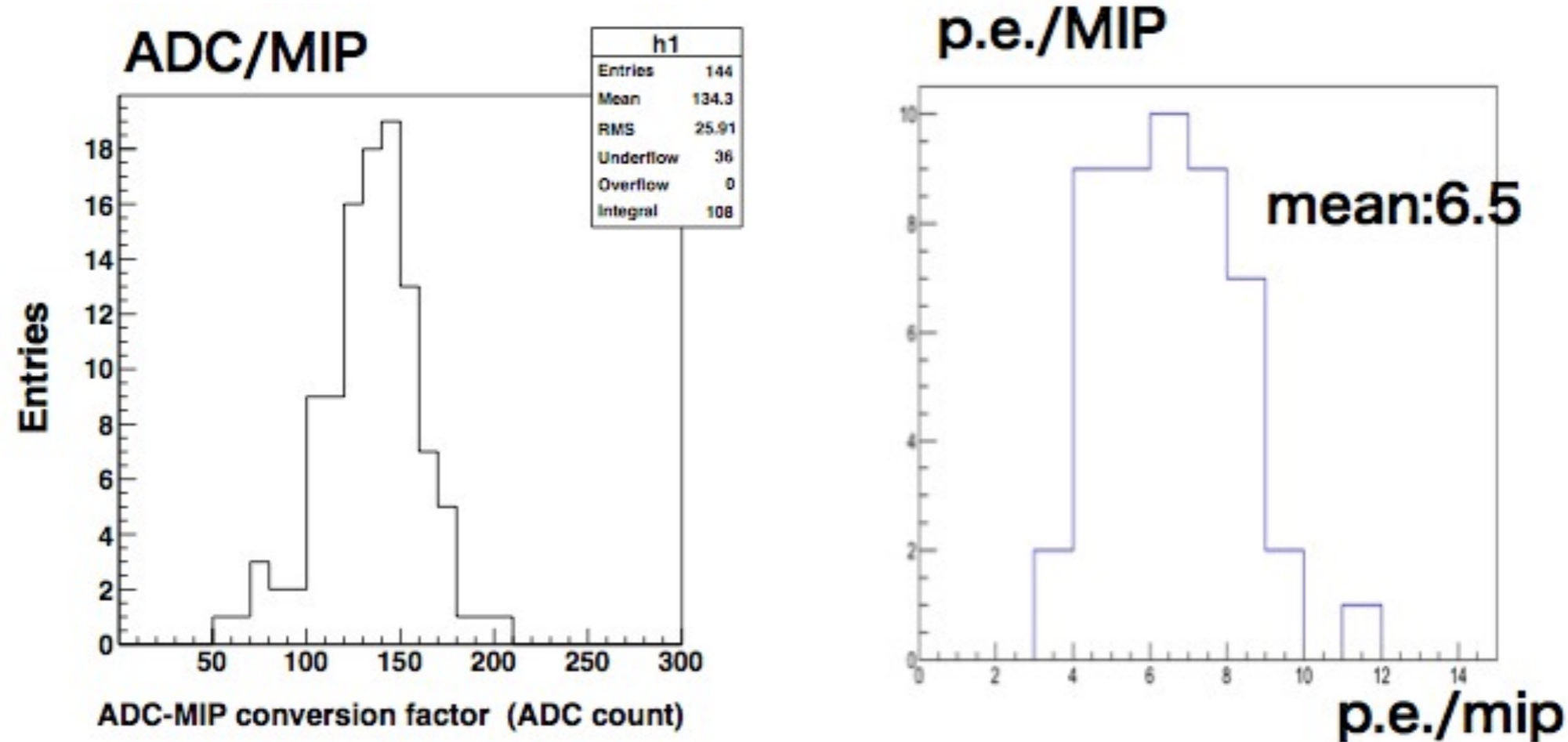
ADC histogram



: no signal or large noise

results of beam data 2012

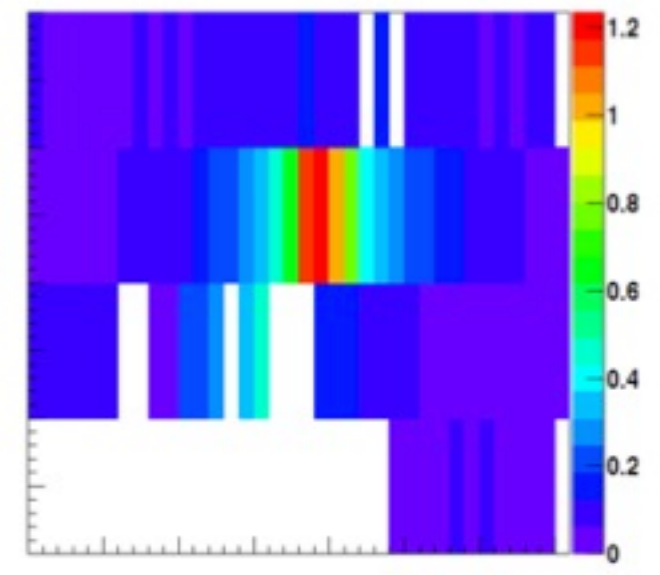
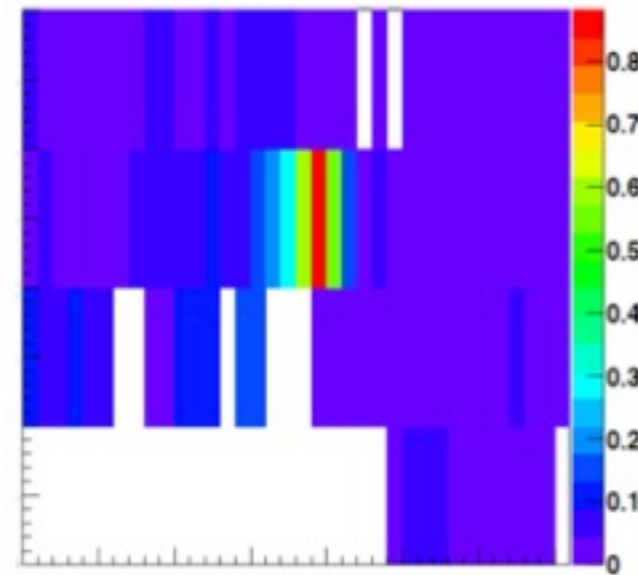
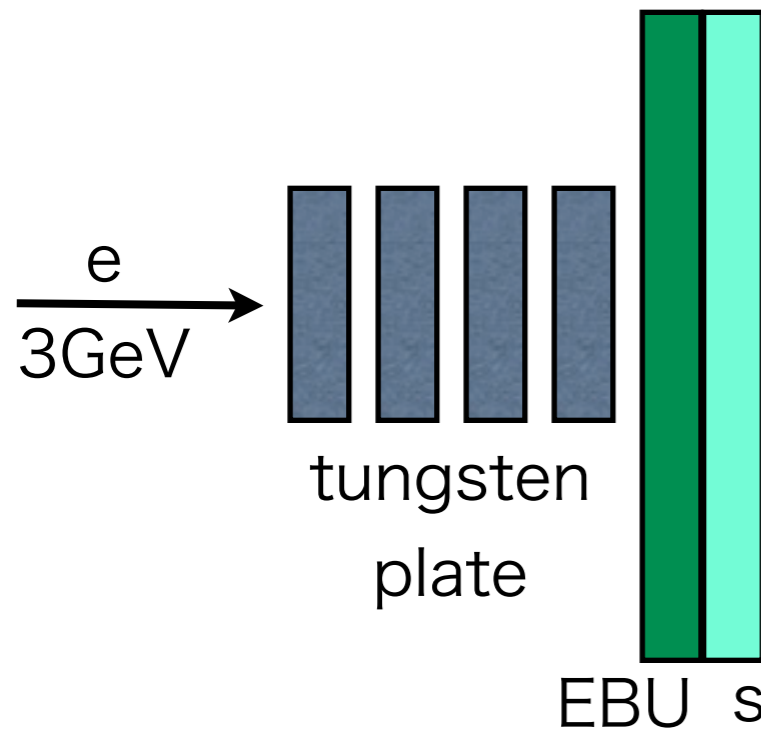
ADC/MIP and #photo-electrons/MIP



- 108 channels out of total 144 ch. (75%).
- RMS/Means = 19.3%
(This is the similar to the case of FNAL physics prototype).
- mean = 6.5 is near the requirement,
we need to increase gains for lower response channels (2-5 p.e.)
 - seven photo-electron is required for the real calorimeter
to remove thermal noise and keep response for bhabha events

Shower events

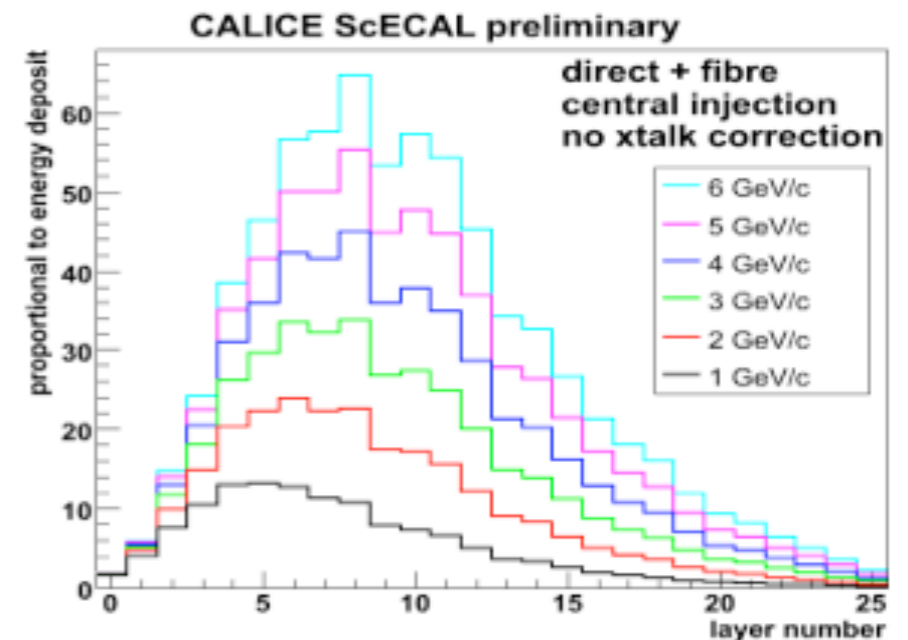
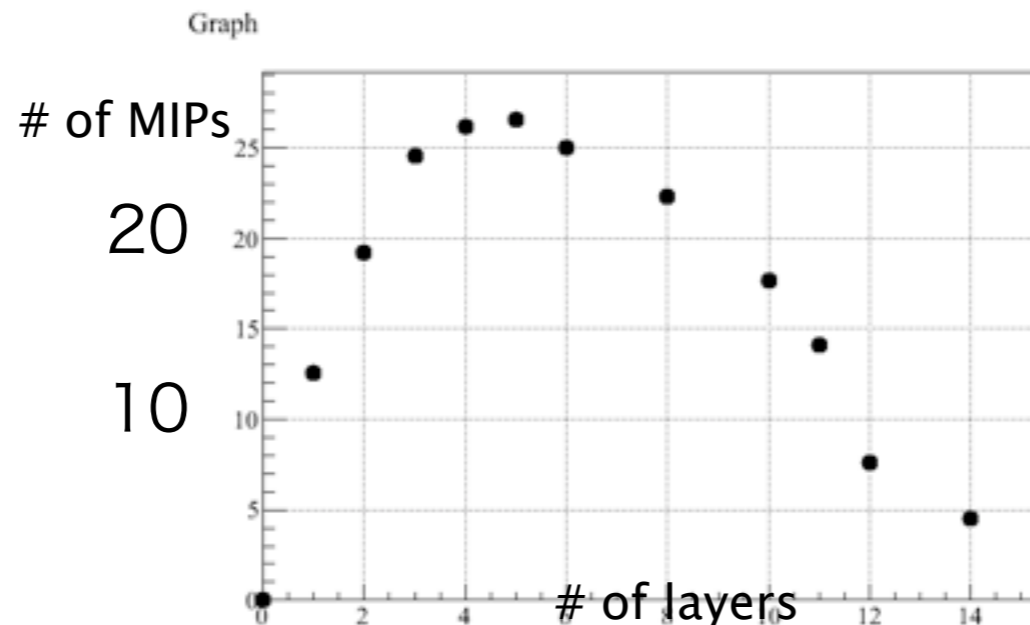
▶ Putting absorber plates in front of EBU, we measure the spread of shower.



▶ longitudinal shower profile comparing with the result of physics prototype

- EBU + scintillator layer

- with physics prototype in 2009



at Shinshu , retested the LED mode

When we use LED mode, for many channels on chip131 and 132 (at DESY only chip 132), signal loss sometimes happen. Once after it happens, Signal loss is kept in the whole of the cycle

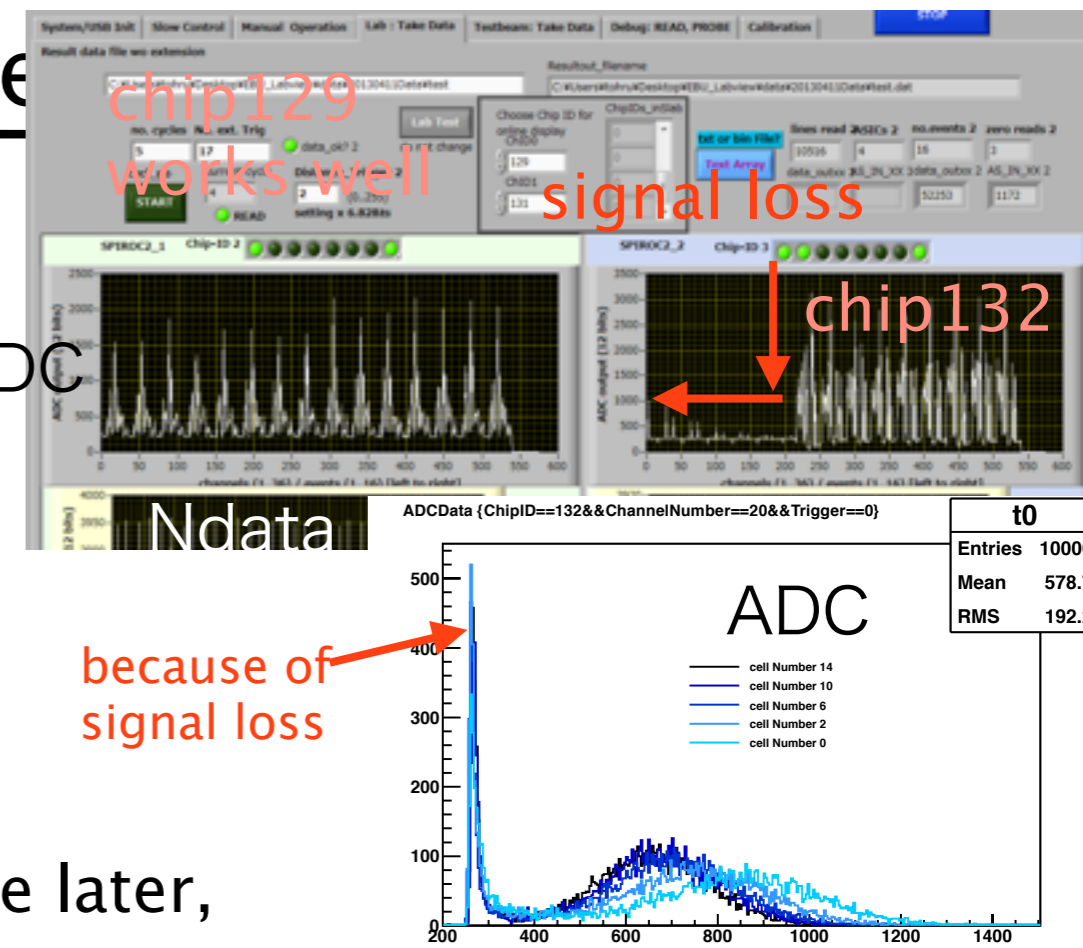
– changing a trigger timing–delay value to become later, they work well.(lower picture)

– the reasons due to LED frequency dependence

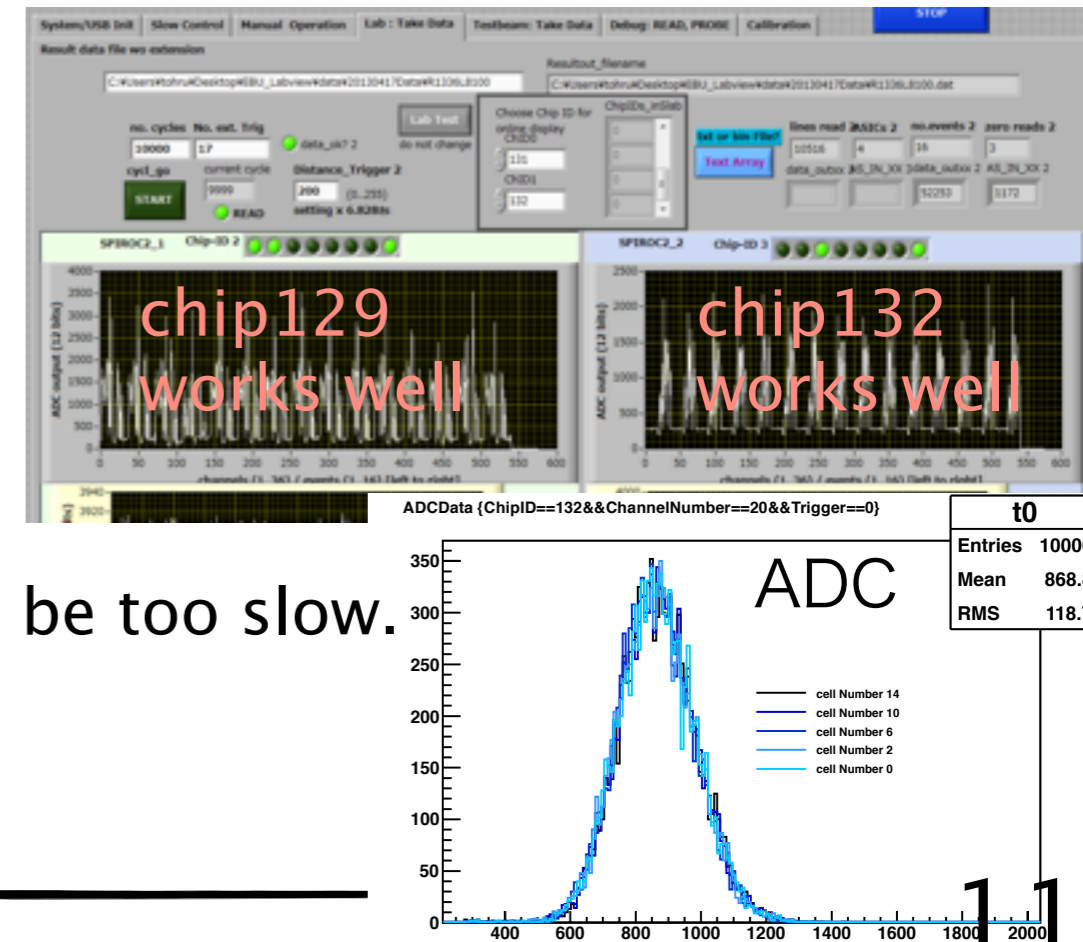
A. the MPPC bias voltage might decrease when the LED frequency is too high .

B. the LED bias voltage might drop

C. the SPIROC channel–wise input DACs might be too slow.



at low frequency LED mode

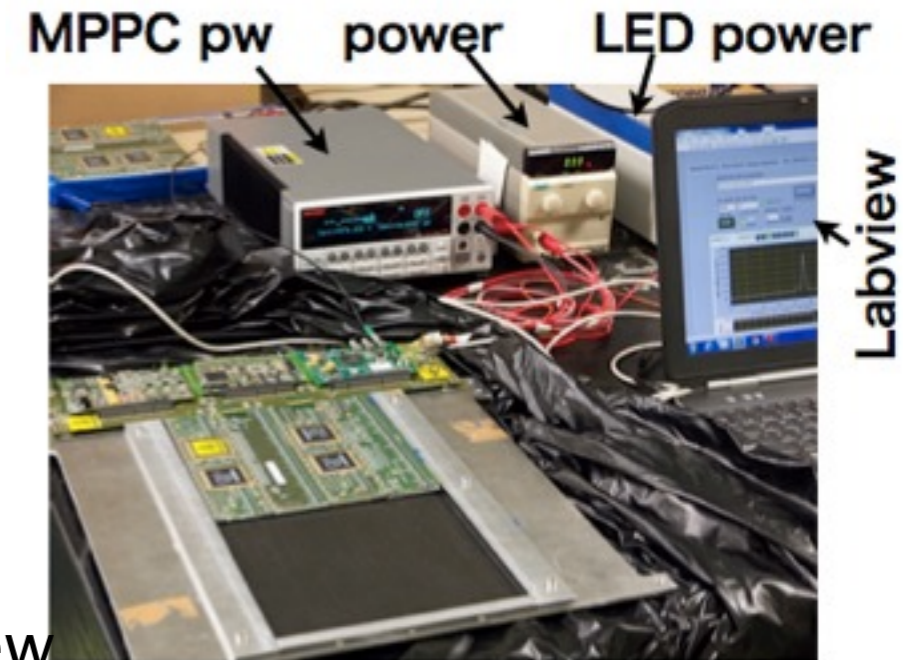


at Shinshu Bad channels at beam were investigated

- ▶ For a few unseparated channels against MIP signal, we rise MPPC's bias voltage. they work well.

due to lower gains

- we could not do pre-experiment well to measure break down voltage of MPPCs.
due to this, we set the wrong DAC value to the Labview.



- ▶ we took out two lanes of scintillators and removed the reflector in front of MPPC, then they work well.

construction fail

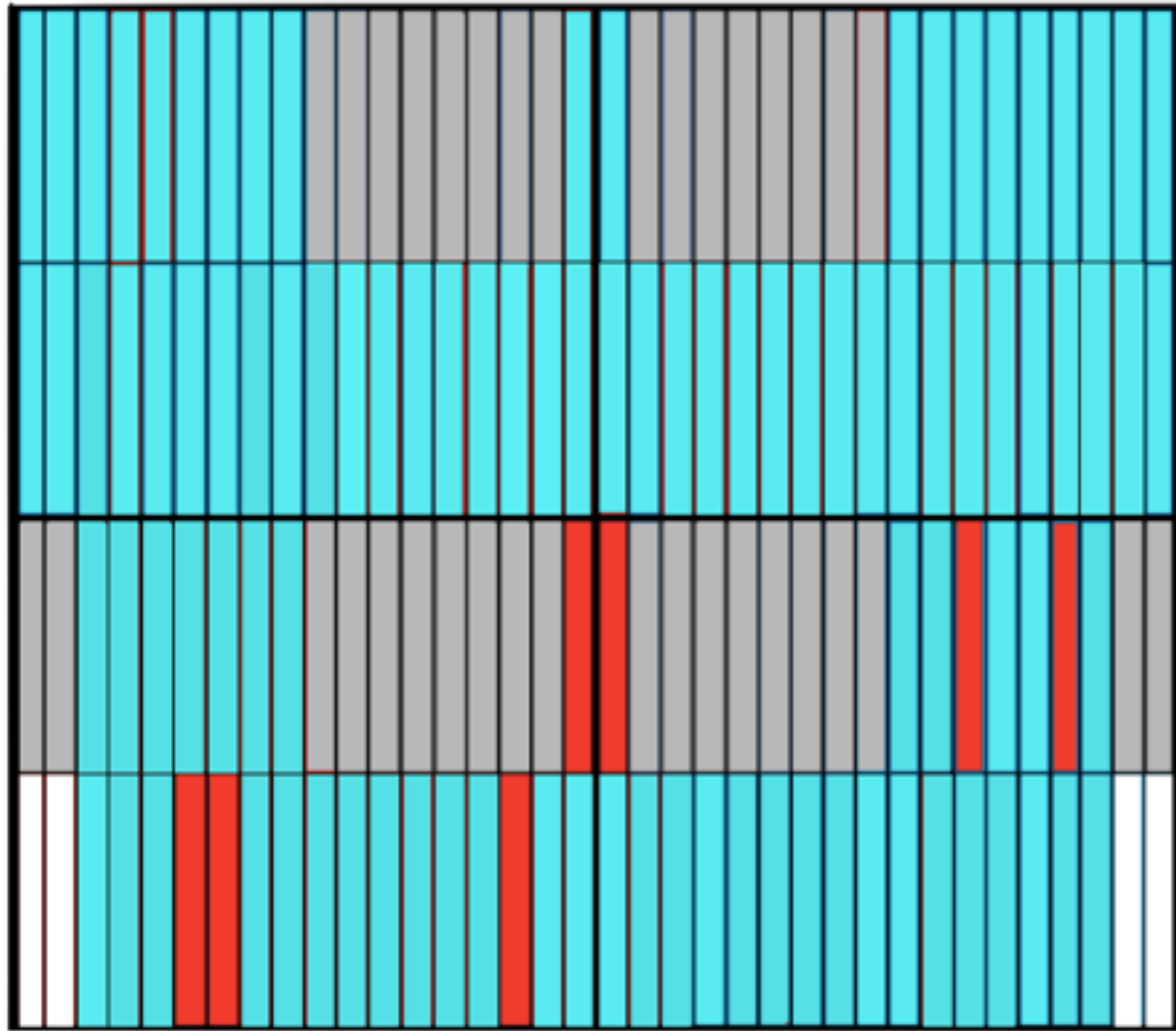
- when we fixed a scintillator layer by hands, a scintillator layer cought a reflector film.



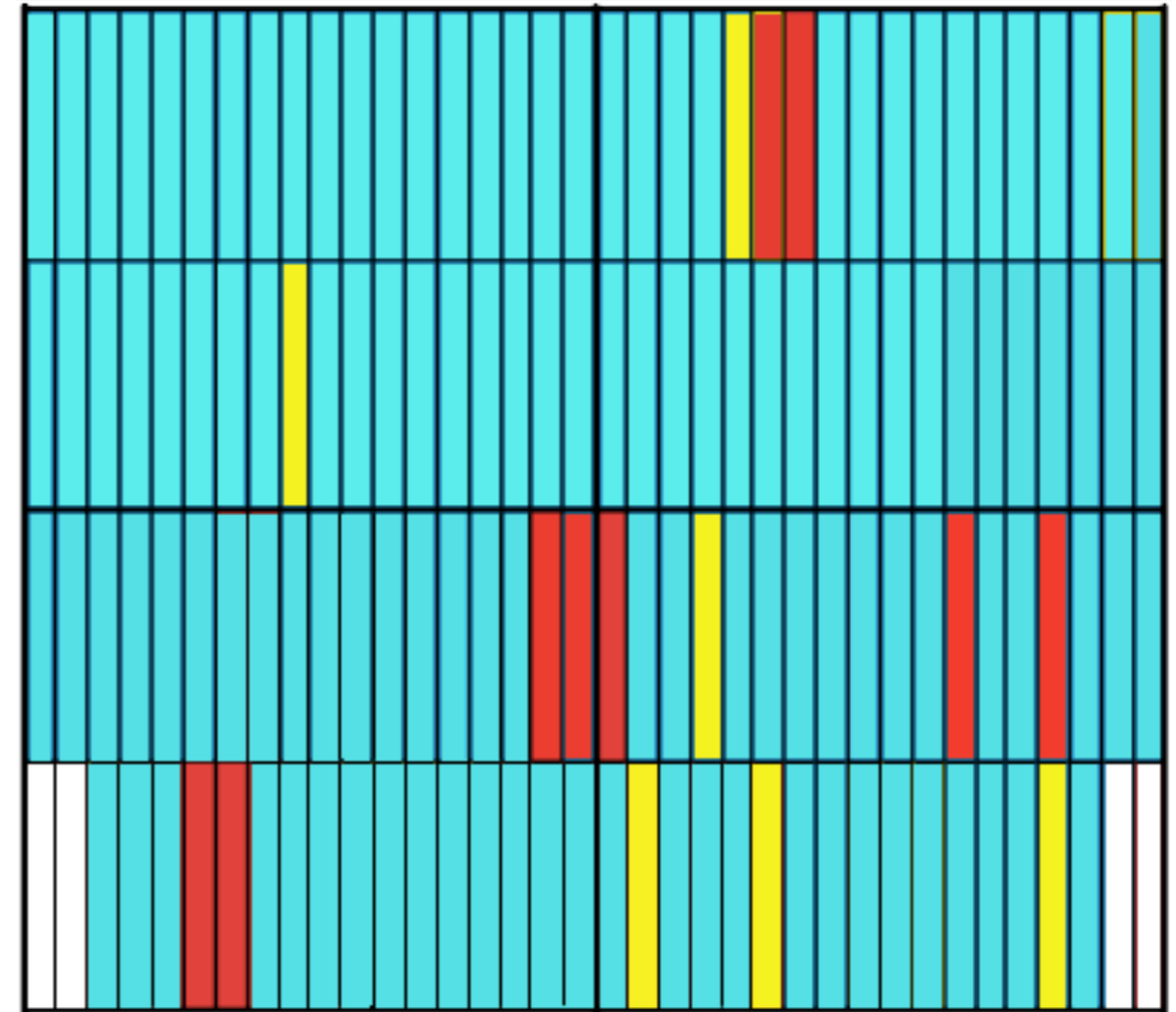
LED calibration results


source test results Sr90

- bias voltage $\Delta V = +2.5$ from break down



- LED calibration result
97ch/108ch ~90% success



still lower biasing at 
- MIP calibration result with Sr90
RI source : 125/144 ~87%

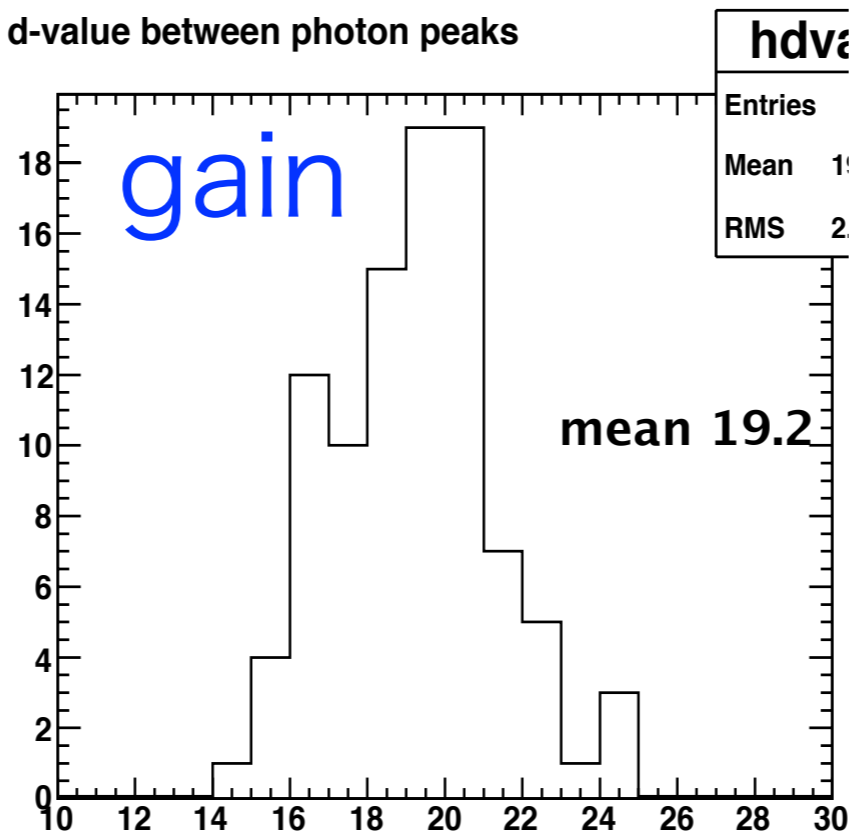
Recovered at Shinshu 2013

▶ result with LED and Sr90 RI source (not include some dead channels)

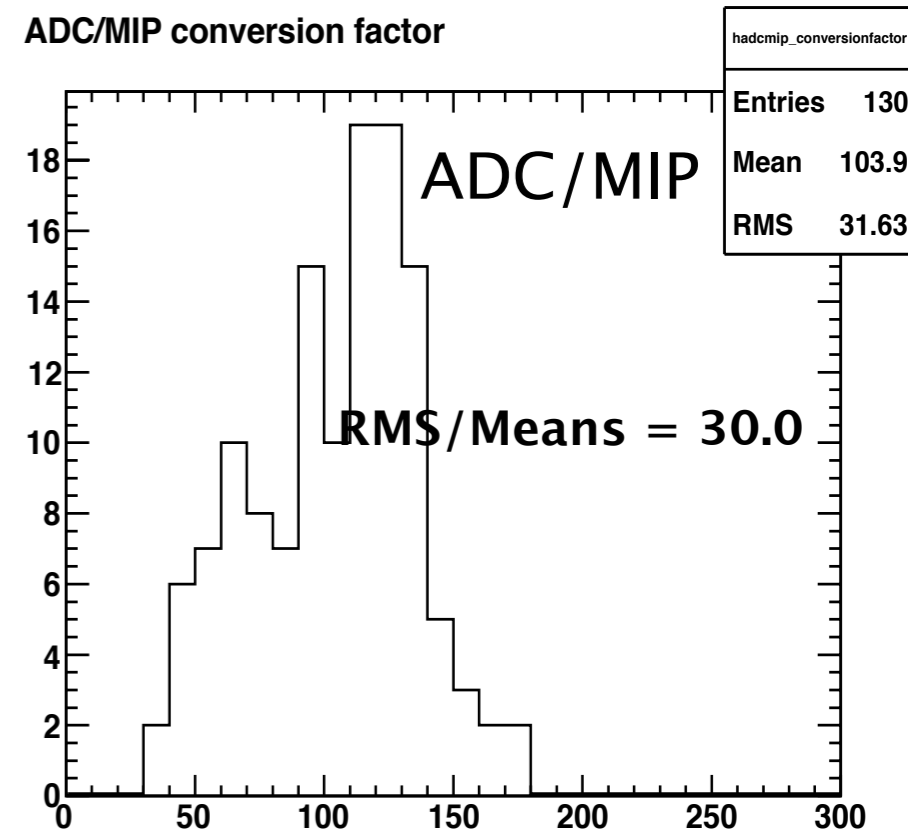
- gains are reasonable

LED: BT to Shinshu
 Nch: 56 to 130
 mean : 20.4 to 19.2

d-value between photon peaks



ADC/MIP conversion factor

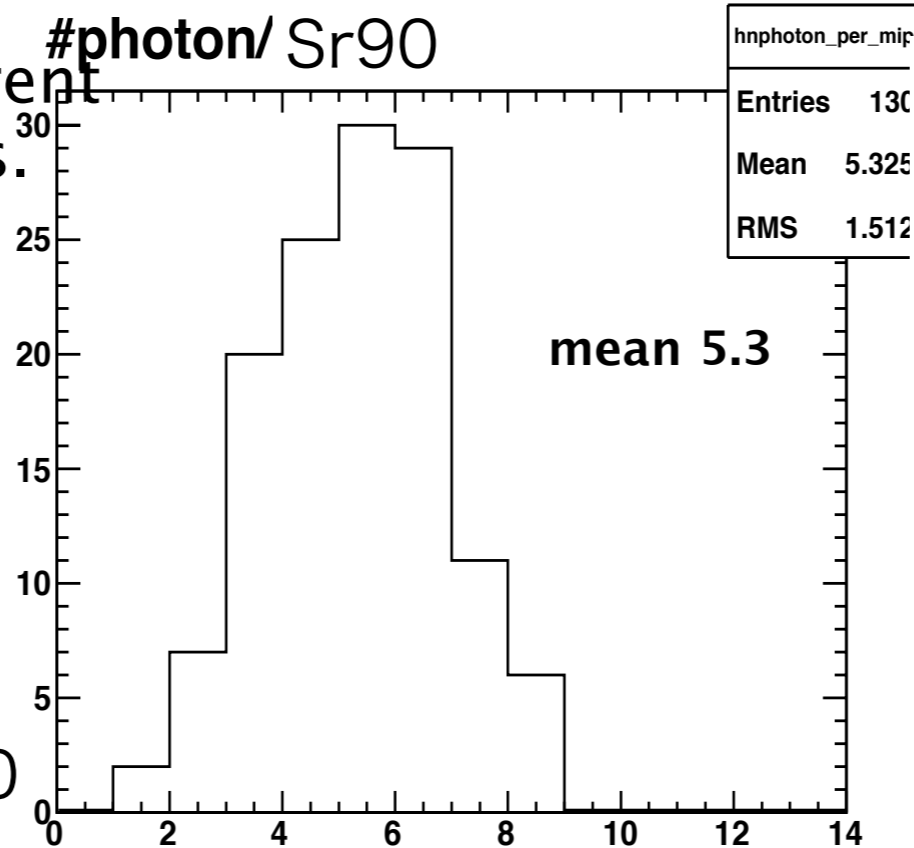


#photon for MPV is not different between control area of ASICs.

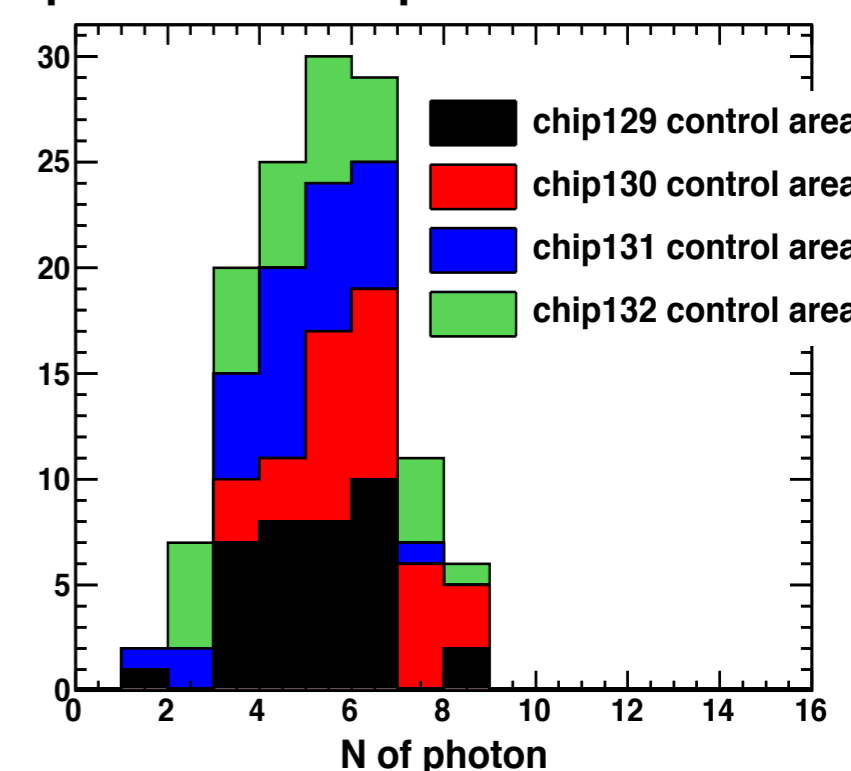
MIP: BT to Shinshu
 Nch: 108 to 130
 mean : 6.5 to 5.3

may be due to source Sr90

#photon/ Sr90



ADC count #photon Sr90 chip control area



Summary and Plan

- We have tested a technological prototype layer 144 channel using electron beam at DESY Oct 2012.
- We have measured the MIP peaks in the energy deposit at around 6.5 p.e. for 75% of channels.
- From TB, we have learnt much, and investigated some problems we have solved some of those problems at shinshu university
 - we could measure d-value on LED mode with 97 channels in 108 equipped LED channels. -> 90%
 - we could measure MPV on TestBeam mode with 125 channels out of 144 channels with Sr90 RI source. -> 87% and the result is MPV of around 5.3 p.e.

plan and outlook

- Next test beam is scheduled at beginning of July, we will test the hybrid ECAL with SiECAL group.
- The purpose is
 - synchronized between Sc layers (not trivial)

Two layers (x and y type) ScECAL prototype

- the **power pulsing mode**
- combined with Si-W-ECAL prototype (Hybrid ECAL) (if possible)

